Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/712,876	PARK ET AL.	
Examiner	Art Unit	
B. Chen	1762	

SEARCHED						
Class	Subclass	Date	Examiner			
updated	previous	9/2/2006	вс			

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
255.29	9/2/2006	ВС			
255.31		1.			
255.7	V	V			
	Subclass 255.29 255.31	Subclass Date 255.29 9/2/2006 255.31			

SEAR((INCLUDING SE	CH NOTES EARCH STRATEGY)
	DATE	EXMR
east	9/2/2006	ВС